

**Adopted Levels, Gammas**

Type	Author	History	Citation	Literature Cutoff Date
Full Evaluation	Alan L. Nichols, Balraj Singh, Jagdish K. Tuli		NDS 113,973 (2012)	15-Apr-2012

$Q(\beta^-) = -1.73 \times 10^4$  syst;  $S(n) = 1.62 \times 10^4$  syst;  $S(p) = 2.05 \times 10^3$  syst;  $Q(\alpha) = -2.03 \times 10^3$  syst    [2012Wa38](#)

Note: Current evaluation has used the following Q record  $-17475$  syst  $16590$  syst  $2440$  syst  $-2370$  syst  
[2011AuZZ](#), [2003Au03](#).

$\Delta Q(\beta^-) = 329$ ,  $\Delta S(n) = 330$ ,  $\Delta S(p) = \Delta Q(\alpha) = 150$  (syst, [2011AuZZ](#), [2003Au03](#)).

$Q(\epsilon p) = 6810$  140 (syst, [2011AuZZ](#), [2003Au03](#)).  $S(2n) = 30776$  240,  $S(2p) = 2647$  140 (syst, [2011AuZZ](#)). [2003Au03](#) list  $S(2n) = 30620$  270,  $S(2p) = 2630$  140 from syst.

[1991Mo10](#):  $^{62}\text{Ge}$  first identified in fragmentation of  $^{78}\text{Kr}$  beam at 65 MeV/nucleon using A1200 spectrometer at NSCL, MSU. Isotopic identification by time-of-flight and energy loss methods.

[2002Lo13](#) (Also [2002Bi17](#)):  $^{62}\text{Ge}$  observed in fragmentation of  $^{78}\text{Kr}$  beam at 73 MeV/nucleon using LISE3 spectrometer at GANIL facility. Isotopic identification by time-of-flight and energy loss methods. Measured isotopic half-life by decay timing of correlated  $\beta^+$  (ion implant) events and energy loss vs time-of-flight.

[2005St29](#) (also [2005St34](#)):  $^{62}\text{Ge}$  observed in fragmentation of  $^{78}\text{Kr}$  beam at 140 MeV/nucleon with a Be target using A1900 spectrometer at NSCL, MSU. Measured cross section=4.8 nb 20.

[2007Bi09](#):  $^{62}\text{Ge}$  observed in fragmentation of  $^{70}\text{Ge}$  beam at 71.6 MeV/nucleon with a Ni target using LISE3 spectrometer at GANIL facility.

Structure calculations:

[1988Do08](#): calculated deformation energy vs quadrupole moment, Hartree-Fock method and Skyrme force.

 **$^{62}\text{Ge}$  Levels****Cross Reference (XREF) Flags**

[A](#)     $^{24}\text{Mg}(^{40}\text{Ca},2\text{n}\gamma)$

E(level)	J <sup>π</sup>	T <sub>1/2</sub>	XREF	Comments
0	0 <sup>+</sup>	129 ms 35	<a href="#">A</a>	%ε+%β <sup>+</sup> =100; %εp=? T <sub>1/2</sub> : from decay curves of (β)(ion implant) correlations ( <a href="#">2002Lo13</a> , <a href="#">2002Bi17</a> ).
964?	†		<a href="#">A</a>	
2285?	†		<a href="#">A</a>	

† In comparison to low-lying structures in  $^{62}\text{Zn}$  and  $^{62}\text{Ga}$ , the 964- and 2285-keV levels may be assigned 2<sup>+</sup> and 4<sup>+</sup>, respectively. However as pointed out by [2005Ru06](#), much better statistics are needed to make definitive assignments.

 **$\gamma(^{62}\text{Ge})$** 

E <sub>i</sub> (level)	E <sub>γ</sub>	E <sub>f</sub>	J <sup>π</sup> <sub>f</sub>
964?	964†	0	0 <sup>+</sup>
2285?	1321†	964?	

† Placement of transition in the level scheme is uncertain.

